

BAR CODE LABEL



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073

GROUP ART UNIT

2212

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CONTINUING DATA***

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STATE OR
COUNTRY

CA

SHEETS
DRAWING

15

TOTAL
CLAIMS

9

INDEPENDENT
CLAIMS

2

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\$730.00

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TITLE

ATOMIC FORCE MICROSCOPE AND METHOD OF OPERATING AN ATOMIC FORCE
MICROSCOPE

This is to certify that annexed hereto is a true copy from the records of the United States
Patent and Trademark Office of the application which is identified above.

By authority of the
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Date

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